

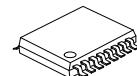
U74AHCT157

CMOS IC

QUADRUPLE 2-LINE TO 1-LINE DATA SELECTOR/ MULTIPLEXER

■ DESCRIPTION

The **U74AHCT157** is a quadruple 2-line to 1-line data selector/multiplexer. When \bar{G} is high, all outputs are low. When \bar{G} is low, a 4-bit word is selected from one of two sources and is routed to the four outputs. The devices provide true data.



TSSOP-16

■ FEATURES

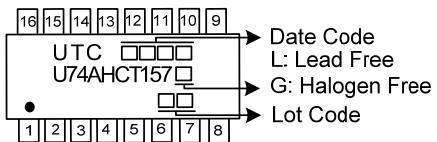
- * TTL-Voltage Compatible
- * Max t_{PD} of 4.1ns from A or B to Y at 5V, $C_L=15\text{pF}$
- * Low Quiescent Current: $I_{CC} = 2 \mu\text{A}$ (MAX) at 5.5V
- * $\pm 8 \text{ mA}$ output driver at 5V

■ ORDERING INFORMATION

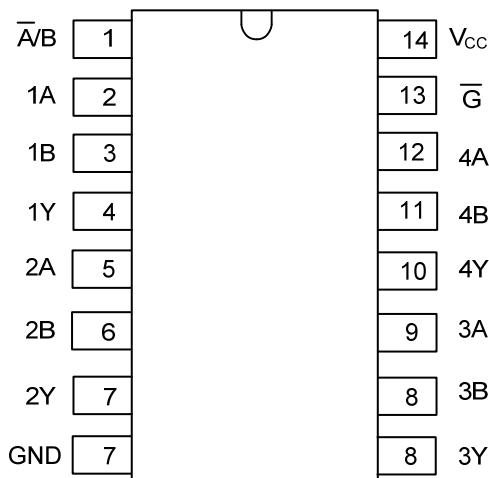
Ordering Number		Package	Packing
Lead Free	Halogen Free		
U74AHCT157L-P16-R	U74AHCT157G-P16-R	TSSOP-16	Tape Reel

U74AHCT157G-P16-R 	(1)Packing Type (2)Package Type (3)Green Package	(1) R: Tape Reel (2) P16: TSSOP-16 (3) G: Halogen Free and Lead Free, L: Lead Free
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■ MARKING



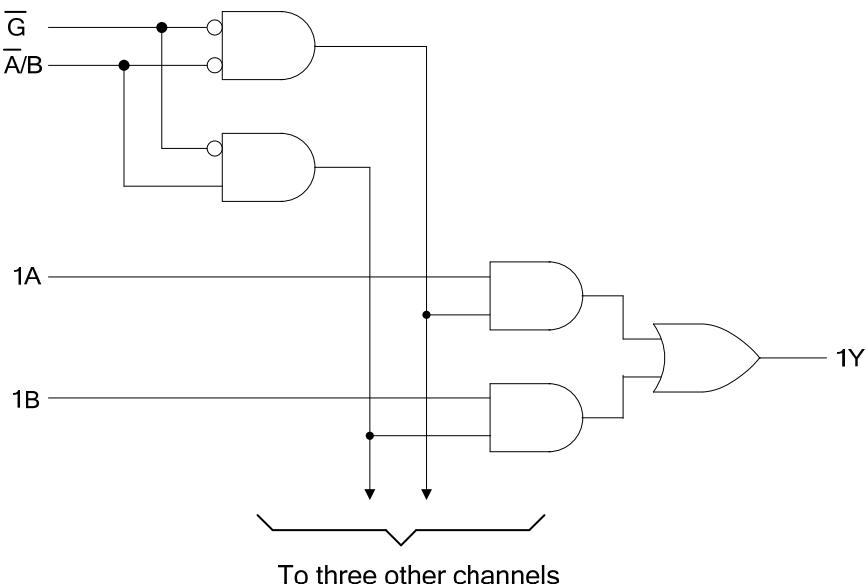
■ PIN CONFIGURATION



■ FUNCTION TABLE

INPUTS				OUTPUTS
\bar{G}	\bar{A}/B	A	B	Y
H	X	X	X	L
L	L	L	X	L
L	L	H	X	H
L	H	X	L	L
L	H	X	H	H

■ LOGIC DIAGRAM



■ ABSOLUTE MAXIMUM RATING (Unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage Range	V _{CC}	-0.5~7	V
Input Voltage Range	V _{IN}	-0.5~7	V
Output Voltage Range	V _{OUT}	-0.5~V _{CC} +0.5	V
Input Clamp Current (V _{IN} <0)	I _{IK}	-20	mA
Output Clamp Current (V _{OUT} <0, or V _{OUT} >V _{CC})	I _{OK}	±20	mA
Output Current	I _{OUT}	±25	mA
V _{CC} or GND Current	I _{CC}	±50	mA
Storage Temperature	T _{STG}	-65 ~ +150	°C

Note: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

■ RECOMMENDED OPERATING CONDITIONS (Unless otherwise specified)

PARAMETER	SYMBOL	RATINGS	UNIT
Supply Voltage	V _{CC}	4.5 ~ 5.5	V
High-Level Input Voltage	V _{IH}	2	V
Low-Level Input Voltage	V _{IL}	0.8	V
Input Voltage	V _{IN}	0 ~ 5.5	V
Output Voltage	V _{OUT}	0 ~ V _{CC}	V
High-Level Output Current	I _{OH}	-8	mA
Low-Level Output Current	I _{OL}	8	mA
Input Rise or Fall Times	Δt/ΔV	20	ns/V
Operating Temperature	T _A	-40 ~ +125	°C

■ ELECTRICAL CHARACTERISTICS (Unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output Voltage High-Level	V _{OH}	V _{CC} =4.5V, I _{OH} =-50μA	4.4	4.5		V
		V _{CC} =4.5V, I _{OH} =-8mA	3.94			
Output Voltage Low-Level	V _{OL}	V _{CC} =4.5V, I _{OL} =50μA			0.1	V
		V _{CC} =4.5V, I _{OL} =8mA			0.36	
Input Leakage Current	I _{I(LEAK)}	V _{CC} =0V to 5.5V, V _{IN} =0 or 5.5V			±0.1	μA
Quiescent Supply Current	I _{CC}	V _{CC} =5.5V, V _{IN} =V _{CC} or GND, I _{OUT} =0			2	μA
Additional quiescent supply current	ΔI _{CC}	V _{CC} =5.5V, one input at 3.4V, Other inputs at V _{CC} or GND			1.35	mA
Input Capacitance	C _I	V _{CC} =5V, V _{IN} =V _{CC} or GND		2	10	pF

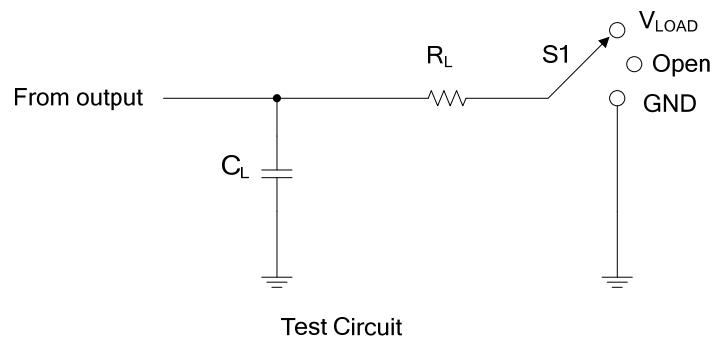
■ SWITCHING CHARACTERISTICS ($V_{CC}=5V\pm 0.5V$, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Propagation delay from input A or B to output Y, t_{PD}	t_{PLH}	$C_L=15pF, R_L=1k\Omega$		4.1	6.4	ns
		$C_L=50pF, R_L=1k\Omega$		5.6	8.7	
	t_{PHL}	$C_L=15pF, R_L=1k\Omega$		4.1	6.4	ns
		$C_L=50pF, R_L=1k\Omega$		5.6	8.7	
Propagation delay from input \bar{A} / B to output Y, t_{PD}	t_{PLH}	$C_L=15pF, R_L=1k\Omega$		5.3	8.1	ns
		$C_L=50pF, R_L=1k\Omega$		6.8	10.4	
	t_{PHL}	$C_L=15pF, R_L=1k\Omega$		5.3	8.1	ns
		$C_L=50pF, R_L=1k\Omega$		6.8	10.4	
Propagation delay from input \bar{G} to output Y, t_{PD}	t_{PLH}	$C_L=15pF, R_L=1k\Omega$		5.6	8.6	ns
		$C_L=50pF, R_L=1k\Omega$		7.1	11	
	t_{PHL}	$C_L=15pF, R_L=1k\Omega$		5.6	8.6	ns
		$C_L=50pF, R_L=1k\Omega$		7.1	11	

■ OPERATING CHARACTERISTICS (Unless otherwise specified)

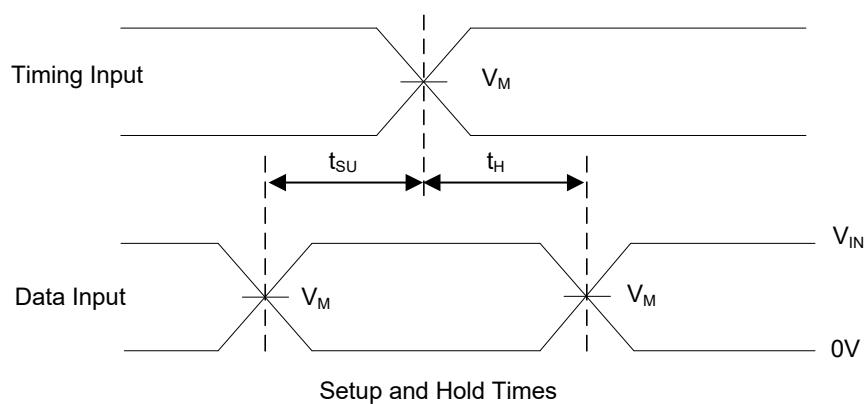
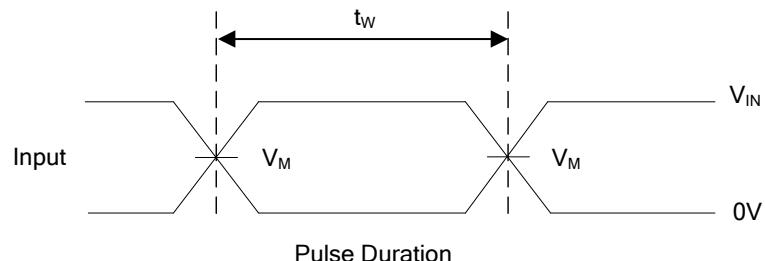
PARAMETER	SYMBOL	TEST CONDITIONS	RATINGS	UNIT
Power dissipation capacitance	C_{PD}	$V_{CC} = 5V, f=1MHz, \text{No load}$	11	pF

■ TEST CIRCUIT AND WAVEFORMS

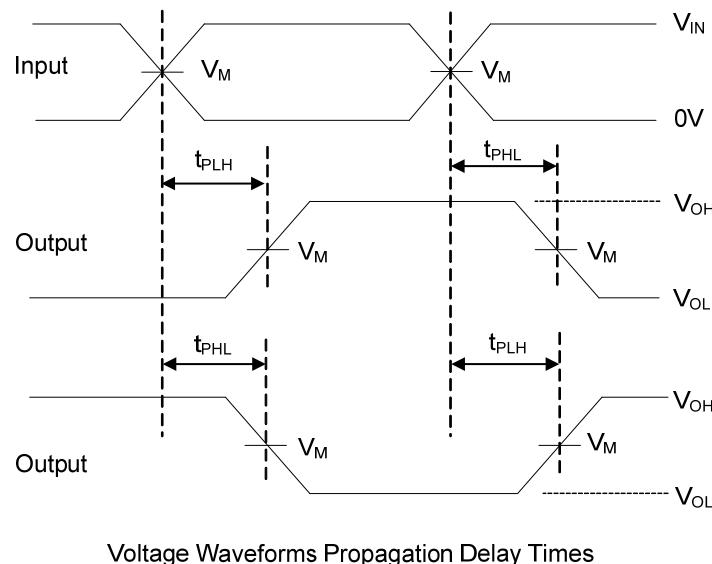


TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	V_{LOAD}
t_{PHZ}/t_{PZH}	GND

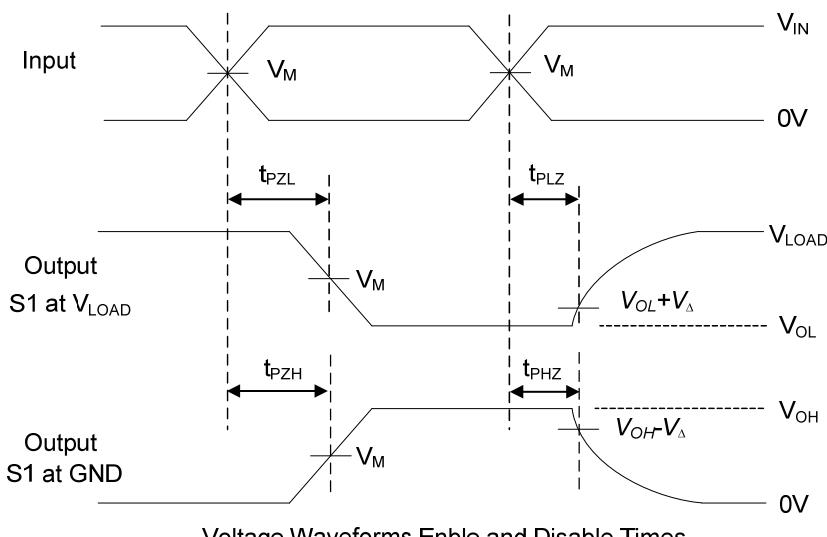
V_{CC}	Input		V_M	V_{LOAD}	C_L	R_L	V_Δ
	V_{IN}	t_R, t_F					
$5V \pm 0.5V$	V_{CC}	$\leq 3ns$	$V_{CC}/2$	V_{CC}	15pF 50pF	1k Ω	0.5V



■ TEST CIRCUIT AND WAVEFORMS (Cont.)



Voltage Waveforms Propagation Delay Times



Voltage Waveforms Enable and Disable Times

Notes: 1. C_L includes probe and jig capacitance.

2. All input pulses are supplied by generators having the following characteristics: $P_{RR} \leq 1\text{MHz}$, $Z_O = 50\Omega$.

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